Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/090,168	HIROSHIGE ET	AL.
Examiner	Art Unit	
Madeleine AV Nguyen	2626	

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Class	Subclass	Date	Examiner
358	1.9	10/3/2005	· AV
	518		
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358	530		
382	167		
382	162	10/3/2005	AV

INT	INTERFERENCE SEARCHED		
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		DATE	EXMR
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